

[Bibliography]

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[Title] Gap measurement device for measuring a gap between a mask and a substrate using a laser displacement sensor, and measuring method thereof

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[Request for Examination] Requested

[Purpose] We file as above according to Art. 42 of the Patent Law, request the examination as above according to Art. 60 of the Patent Law.
Attorney Youngpil Lee
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[Fee]

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[Transfer of Technology] Allowable
[Licensing] Allowable
[Technology Training] Allowable

[Enclosures]

1. Abstract and Specification (and Drawings) 1 copy